

# MBN1500E33E2

Silicon N-channel IGBT 3300V E2 version

## FEATURES

- \* Soft switching behavior & low conduction loss:  
Soft low-injection punch-through High conductivity IGBT.
- \* Low driving power due to low input capacitance MOS gate.
- \* Low noise recovery: Ultra soft fast recovery diode.
- \* High thermal fatigue durability:  
( $\Delta T_c=70K$ ,  $N>30,000$ cycles)  
AlSiC base-plate/AlN substrate

## ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ\text{C}$ )

Item	Symbol	Unit	MBN1500E33E2
Collector Emitter Voltage	$V_{CES}$	V	3,300
Gate Emitter Voltage	$V_{GES}$	V	$\pm 20$
Collector Current	DC	$I_C$	1,500 ( $T_c=95^\circ\text{C}$ )
	1ms	$I_{Cp}$	3,000
Forward Current	DC	$I_F$	1,500
	1ms	$I_{FM}$	3,000
Junction Temperature	$T_j$	$^\circ\text{C}$	-40 ~ +150
Storage Temperature	$T_{stg}$	$^\circ\text{C}$	-50 ~ +125
Isolation Voltage	$V_{ISO}$	$V_{RMS}$	6,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/15 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value  $1.8 \pm 0.2/15^{+0}_{-3} \text{N}\cdot\text{m}$

(2) Recommended Value  $5.5 \pm 0.5 \text{N}\cdot\text{m}$

## ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	$I_{CES}$	mA	-	-	12	$V_{CE}=3,300\text{V}$ , $V_{GE}=0\text{V}$ , $T_j=25^\circ\text{C}$
Gate Emitter Leakage Current	$I_{GES}$	nA	-500	-	+500	$V_{CE}=3,300\text{V}$ , $V_{GE}=0\text{V}$ , $T_j=125^\circ\text{C}$ $V_{GE}=\pm 20\text{V}$ , $V_{CE}=0\text{V}$ , $T_j=25^\circ\text{C}$
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	2.5	2.95	3.5	$I_C=1,500\text{A}$ , $V_{GE}=15\text{V}$ , $T_j=125^\circ\text{C}$
			-	3.1	-	$I_C=1,500\text{A}$ , $V_{GE}=15\text{V}$ , $T_j=150^\circ\text{C}$
Gate Emitter Threshold Voltage	$V_{GE(To)}$	V	5.5	6.3	7.5	$V_{CE}=10\text{V}$ , $I_C=1,500\text{mA}$ , $T_j=25^\circ\text{C}$
Input Capacitance	$C_{ies}$	nF	-	195	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_j=25^\circ\text{C}$
Internal Gate Resistance	$R_{ge}$	$\Omega$	-	1.0	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_j=25^\circ\text{C}$
Switching Times	Rise Time	$t_r$	1.6	2.0	2.6	$V_{CC}=1,650\text{V}$ , $I_C=1,500\text{A}$
	Turn On Time	$t_{on}$	2.0	3.0	3.7	$L_s=100\text{nH}$
	Fall Time	$t_f$	0.9	1.7	2.6	$R_G=2.7\Omega/2.7\Omega$ , $C_{GE}=330\text{nF}$ (3)
	Turn Off Time	$t_{off}$	2.7	4.4	5.5	$V_{GE}=\pm 15\text{V}$ , $T_j=125^\circ\text{C}$
Peak Forward Voltage Drop	$V_{FM}$	V	2.2	2.6	3.0	$I_F=1,500\text{A}$ , $V_{GE}=0\text{V}$ , $T_j=125^\circ\text{C}$
			-	2.6	-	$I_F=1,500\text{A}$ , $V_{GE}=0\text{V}$ , $T_j=150^\circ\text{C}$
Reverse Recovery Time	$t_{rr}$	$\mu\text{s}$	0.2	0.8	1.2	$V_{CC}=1,650\text{V}$ , $I_F=1,500\text{A}$ , $L_s=100\text{nH}$ $T_j=125^\circ\text{C}$
Short Circuit Pulse Width	$t_{sc}$	$\mu\text{s}$	10	-	-	$V_{CC}=2000\text{V}$ , $L_s=80\text{nH}$ $R_G(\text{on/off})=2.7/27\Omega$ , $V_{GE}=\pm 15\text{V}$ , $T_j=125^\circ\text{C}$
Turn On Loss	$E_{on(10\%)}$	J/P	-	2.9	3.6	$T_j=125^\circ\text{C}$
	$E_{on(full)}$		-	3.2	-	$T_j=150^\circ\text{C}$
Turn Off Loss	$E_{off(10\%)}$	J/P	-	2.2	2.6	$T_j=125^\circ\text{C}$
	$E_{off(full)}$		-	2.4	-	$T_j=150^\circ\text{C}$
Reverse Recovery Loss	$E_{rr(10\%)}$	J/P	-	1.4	1.9	$T_j=125^\circ\text{C}$
	$E_{rr(full)}$		-	1.7	-	$T_j=150^\circ\text{C}$

Notes:(3)  $R_G$  and  $C_{GE}$  value are the test condition's value for evaluation of the switching times, not recommended value.

Please, determine the suitable  $R_G$  value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

\* Please contact our representatives at order.

\* For improvement, specifications are subject to change without notice.

\* For actual application, please confirm this spec sheet is the newest revision.

# MBN1500E33E2

## THERMAL CHARACTERISTICS

Item		Symbol	Unit	Min.	Typ.	Max.	Conditions
Thermal Impedance	IGBT	$R_{th(j-c)}$	K/W	-	-	0.0078	Junction to case
	FWD	$R_{th(j-c)}$		-	-	0.0156	
Contact Thermal Impedance		$R_{th(c-f)}$	K/W	-	0.005	-	Case to fin ( $\lambda_{grease}=1W/(m \cdot K)$ , heat-sink flatness $\leq 50\mu m$ )

## MODULE MECHANICAL CHARACTERISTICS

Item		Unit	Characteristics	Conditions
Weight		g	1,300	
Stray inductance in module	LS(CM-EM)	nH	12	Collector-main to Emitter-main
	LS(ES-EM)		49	Emitter-sense to Emitter-main
	LS(CM-CS)		56	Collector-main to Collector sense
Terminal Resistance	$R_{Terminal}$	m $\Omega$	0.09	Collector-main to Emitter-main
Comparative Tracking Index (CTI)			600	
Module base plate Material			Al-SiC	
Baseplate Thickness		mm	5	
Insulation plate Material			Al N	
Terminal Surface treatment			Ni plating	
Case Material			Poly-Phenilene Sulfide	
Fire and Smoke Category			I2 / F3	NFF 16-102

# MBN1500E33E2

## DEFINITION OF TEST CIRCUIT

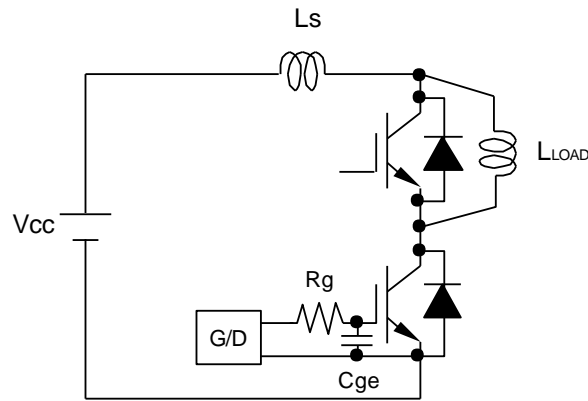


Fig.1 Switching test circuit

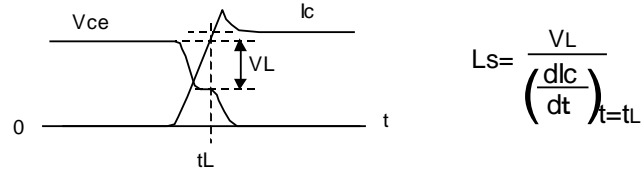


Fig.2 Definition of stray inductance

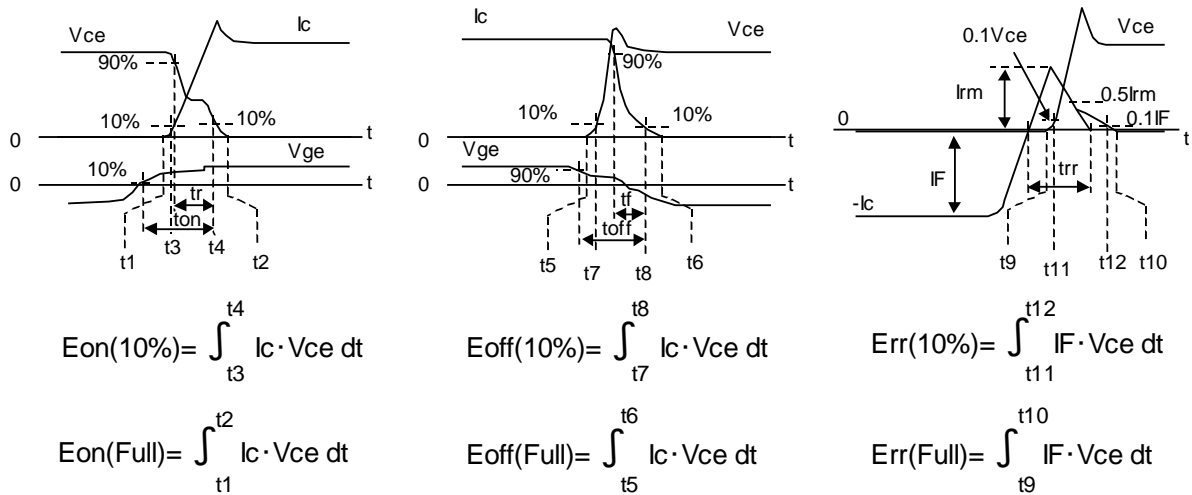
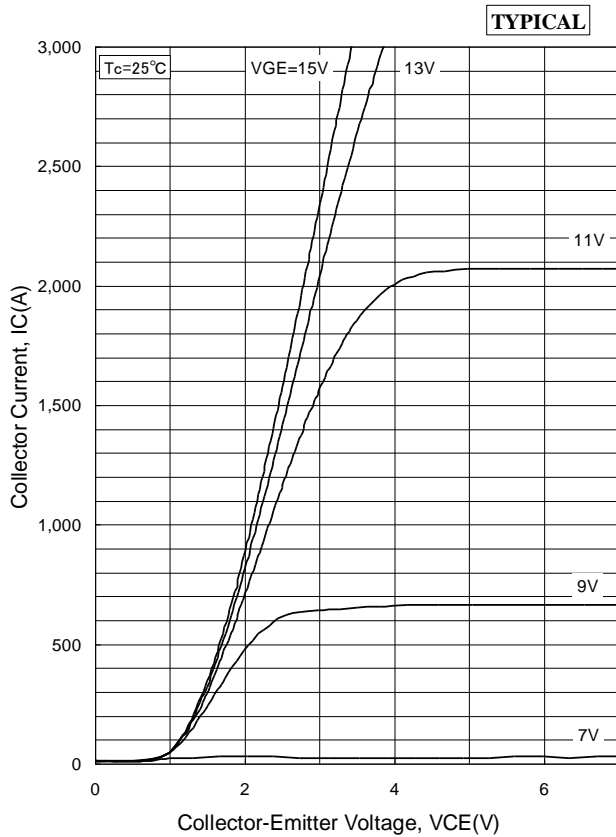


Fig.3 Definition of switching loss

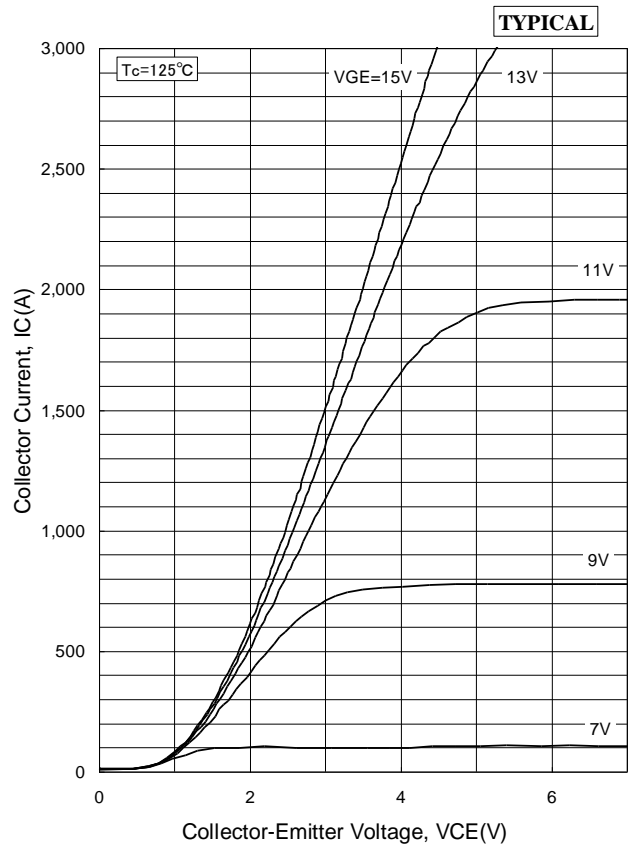
# MBN1500E33E2

## CHARACTERISTICS CURVE

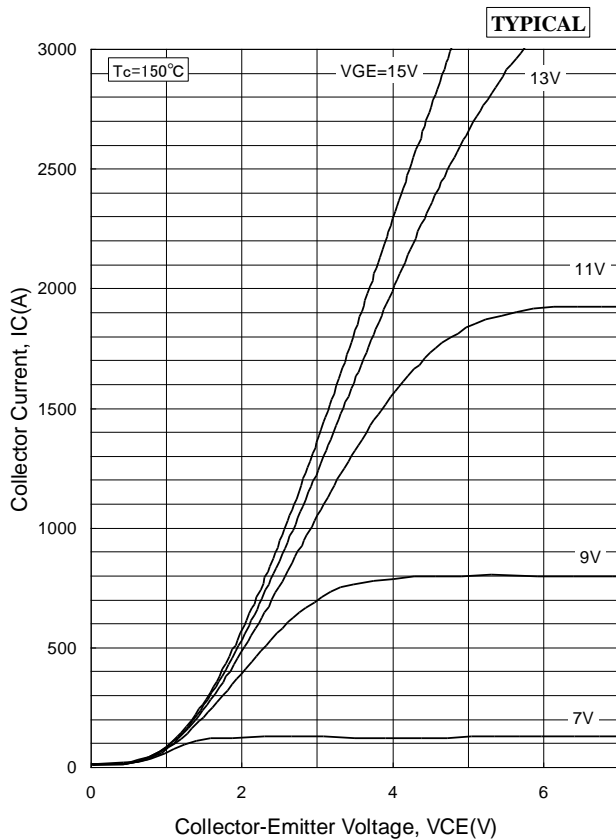
### STATIC CHARACTERISTICS



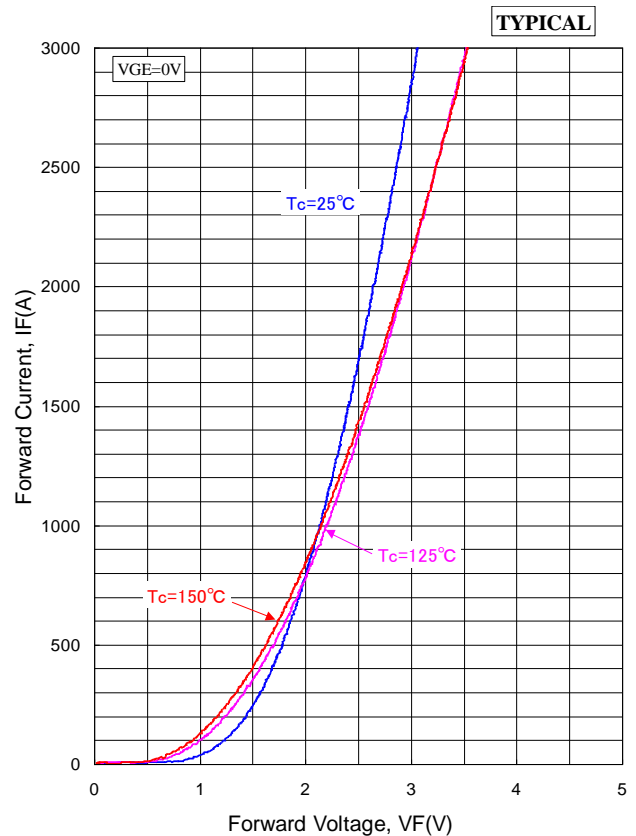
Collector Current vs. Collector to Emitter Voltage



Collector Current vs. Collector to Emitter Voltage



Collector Current vs. Collector to Emitter Voltage

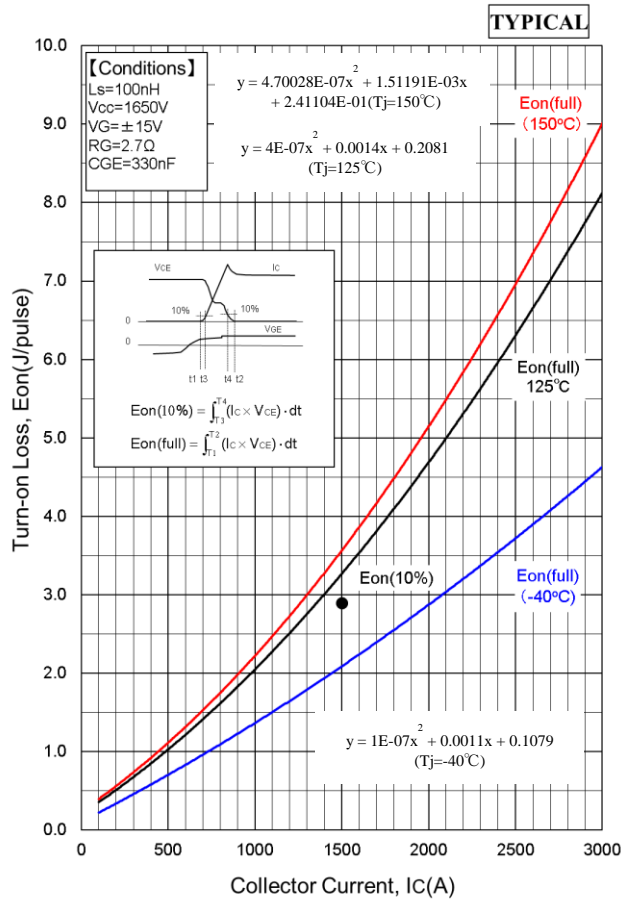


Forward Voltage of free-wheeling diode

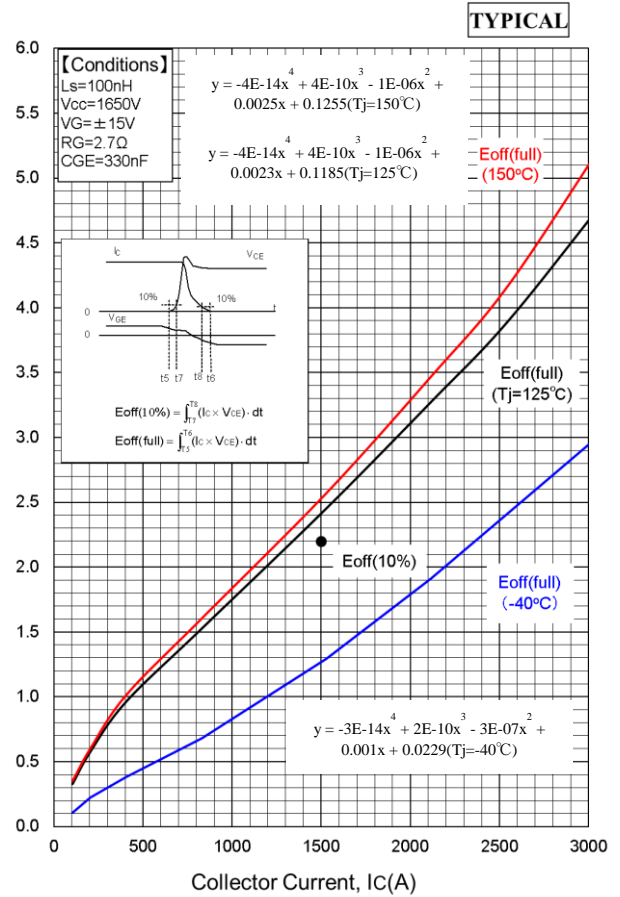
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## DYNAMIC CHARACTERISTICS

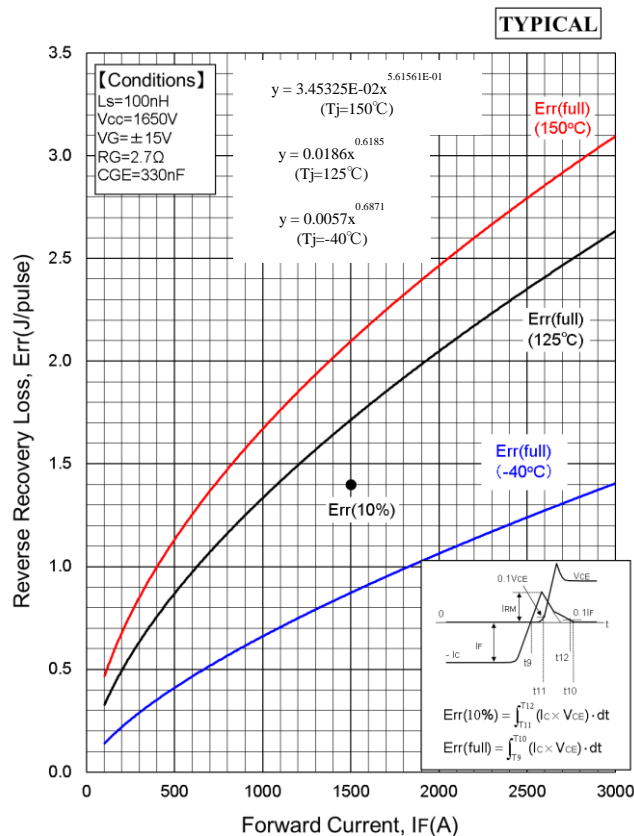
### DEPENDENCE OF CURRENT



Turn-on Loss vs. Collector Current

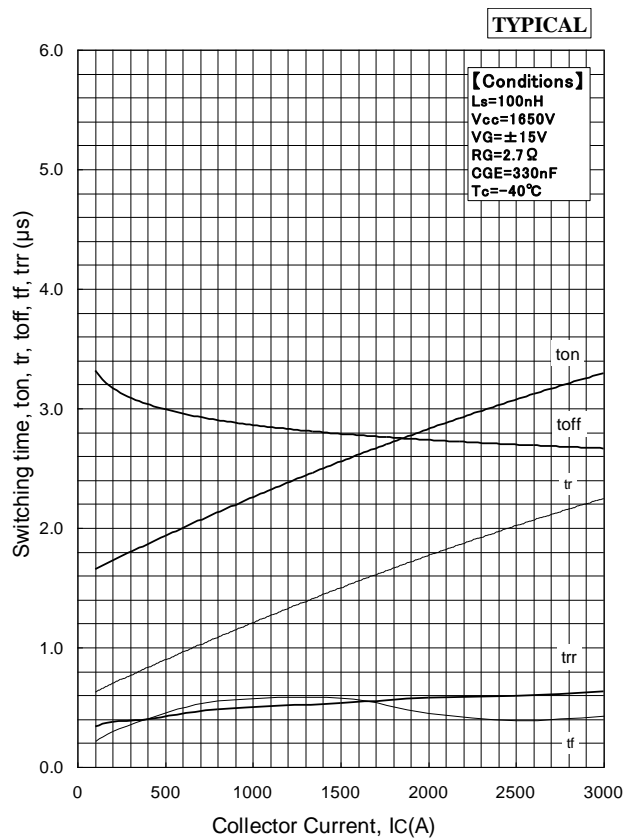
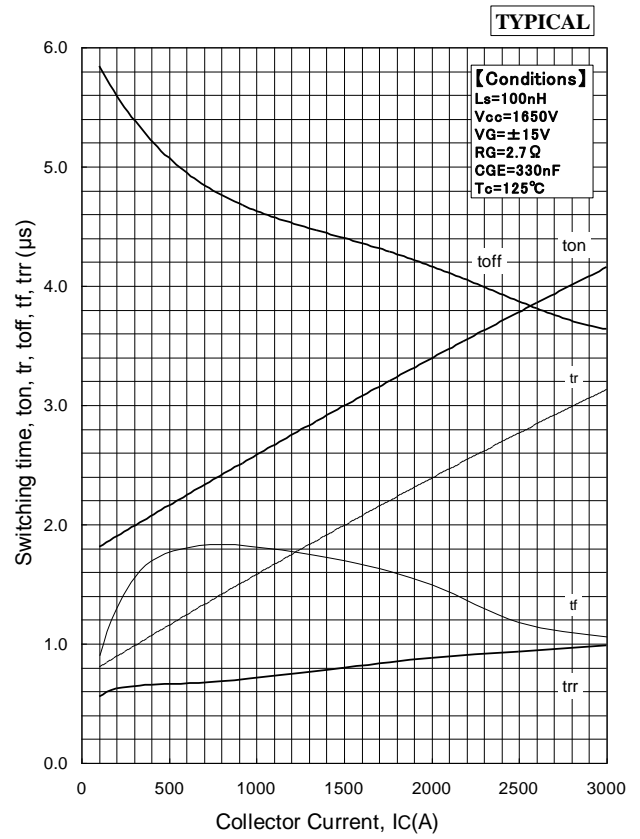
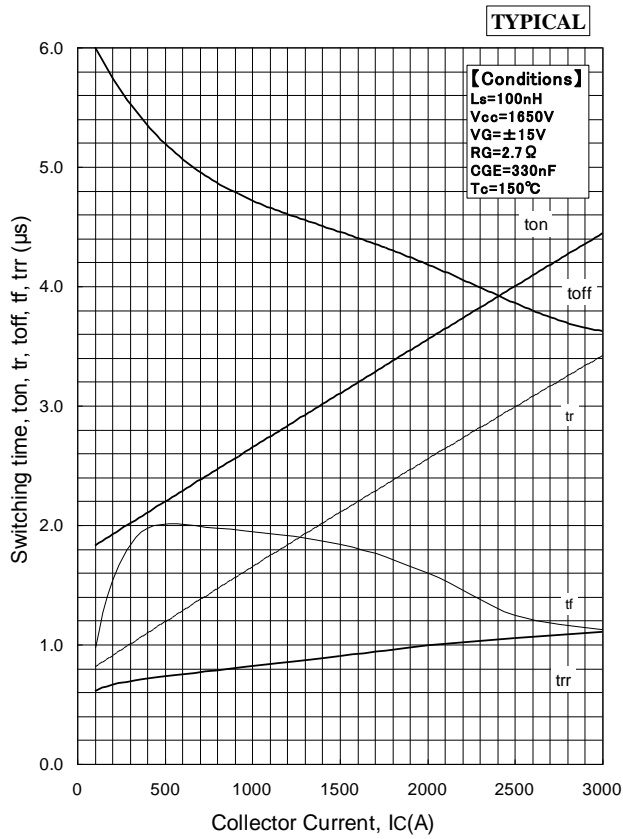


Turn-off Loss vs. Collector Current



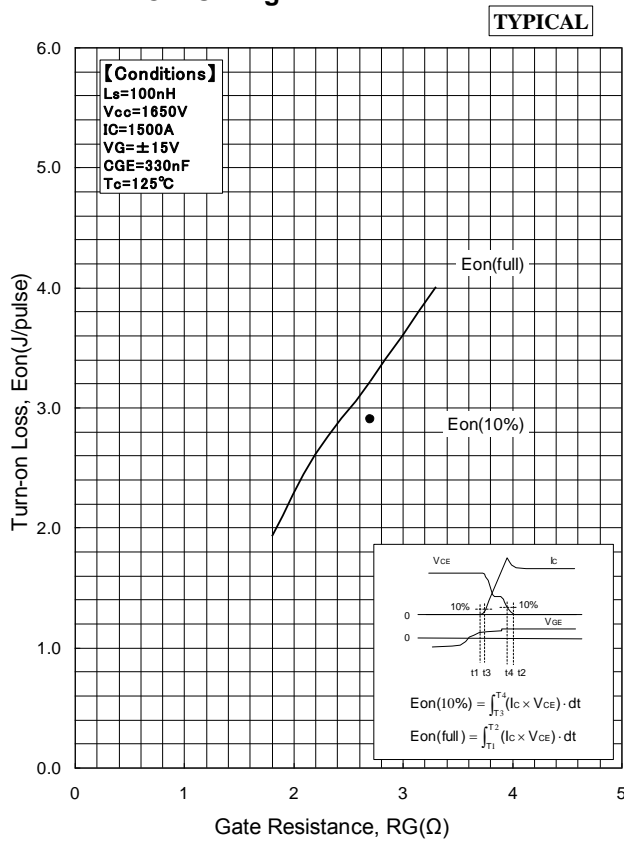
Recovery Loss vs. Forward Current

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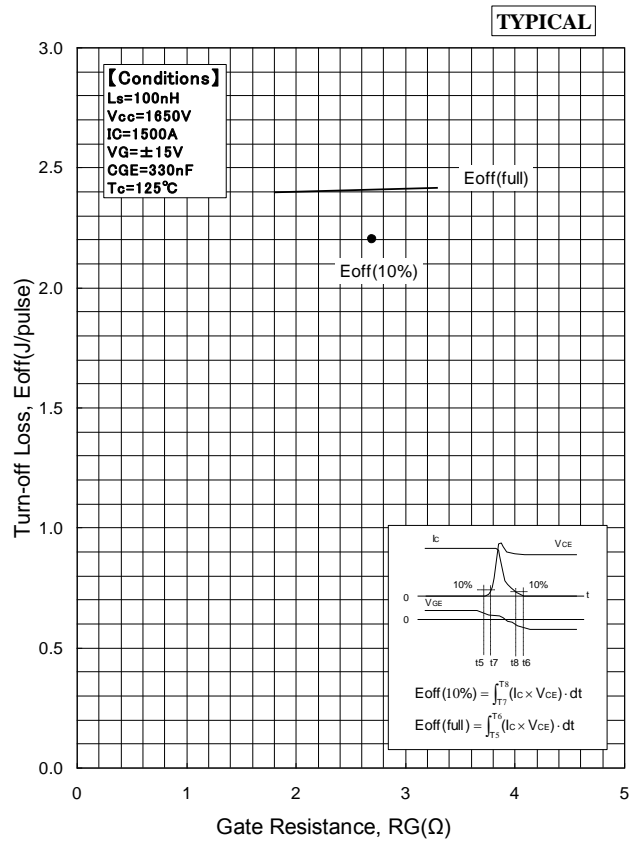


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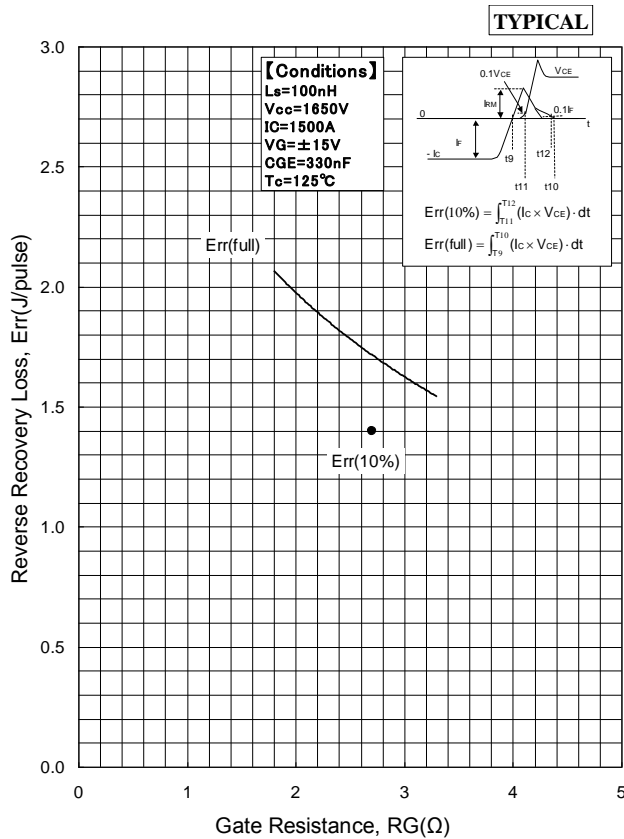
## DEPENDENCE OF Rg



Turn-on Loss vs. Gate Resistance



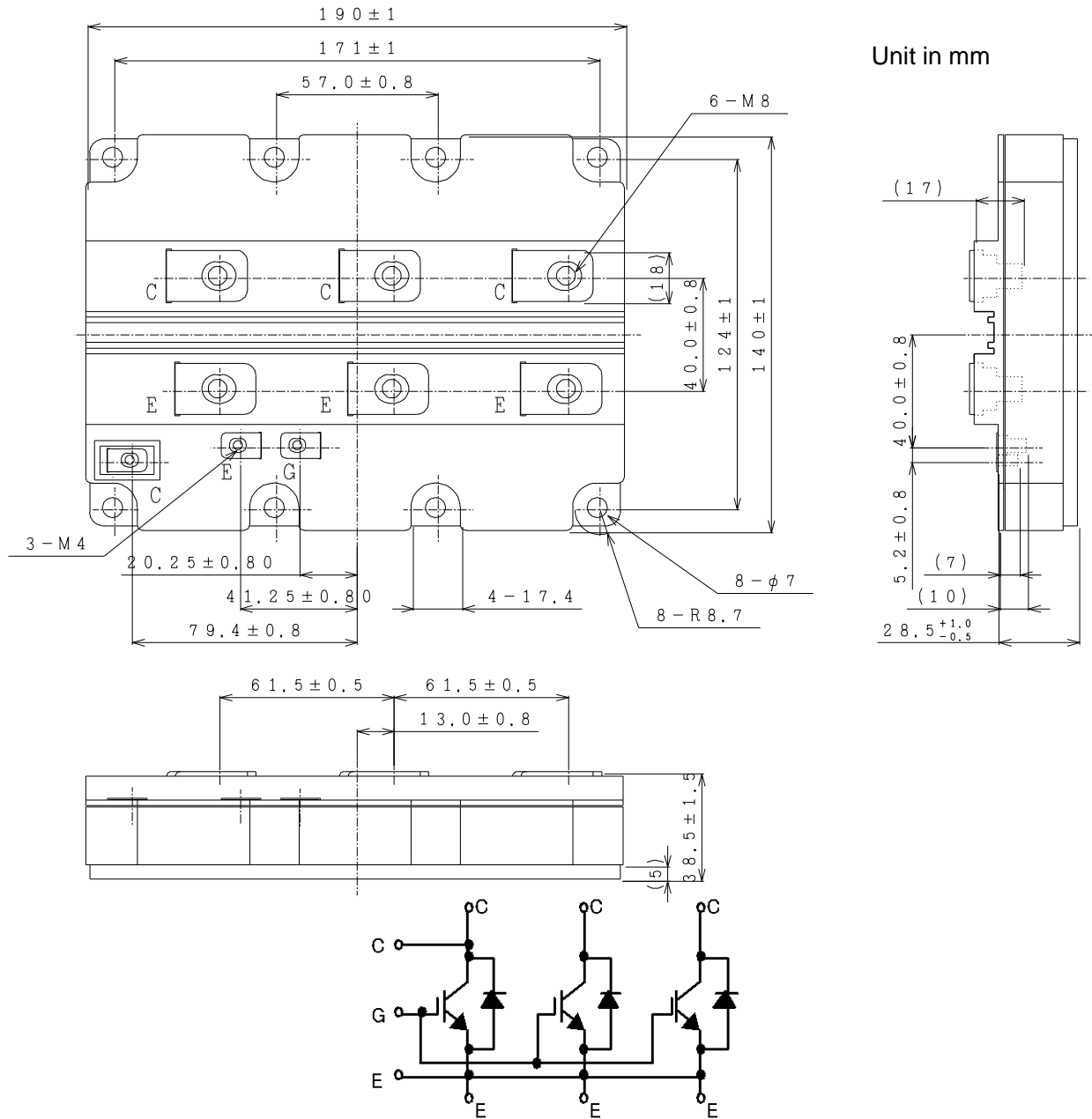
Turn-off Loss vs. Gate Resistance



Recovery Loss vs. Gate Resistance

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## OUTLINE DRAWINGS



Unit in mm

Circuit diagram

### Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

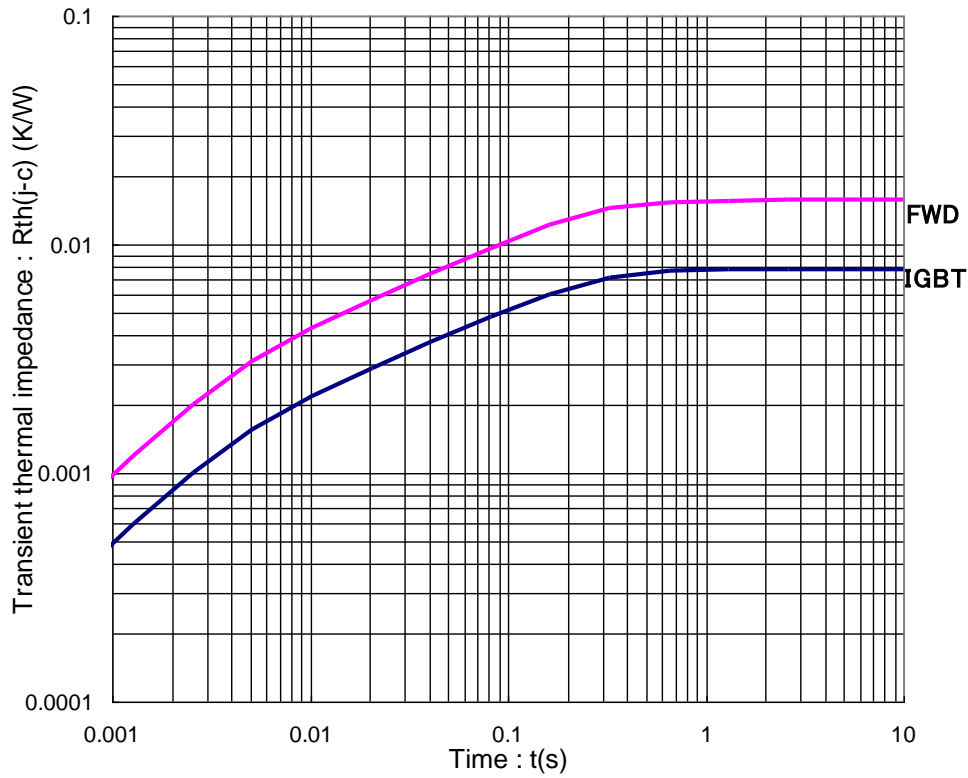
Material	Contained part
Lead (Pb) and its compounds	Solder



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## TRANSIENT THERMAL IMPEDANCE

**Maximum**



### Transient Thermal Impedance Curve

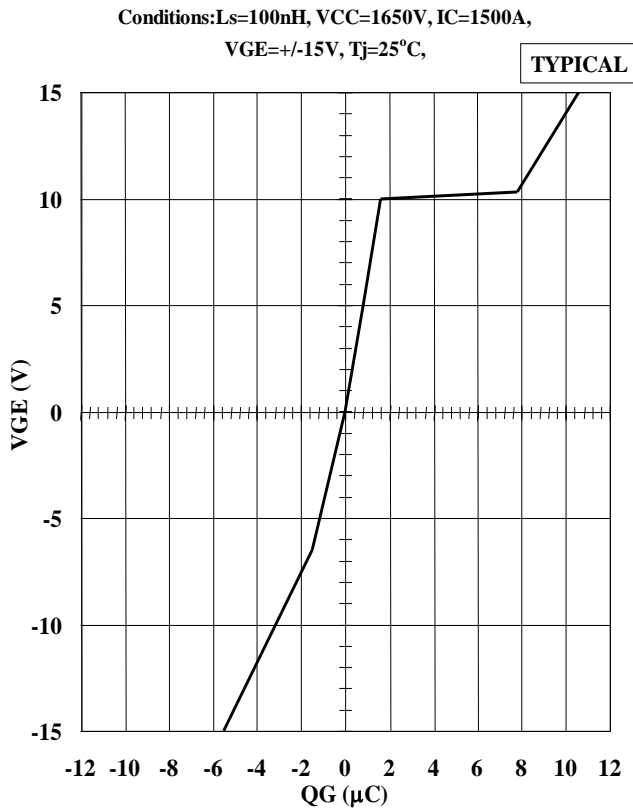
Curve approximation model

$$Z_{th} = \sum r_{th}[n] * (1 - \exp(-t/r_{th}[n]))$$

n	1	2	3	4	Unit
$\tau_{th}[n]$	1.60E-01	2.74E-02	4.04E-03	7.37E-04	sec
$r_{th}[n,IGBT]$	4.83E-03	1.40E-03	1.40E-03	1.43E-04	K/W
$r_{th}[n,Diode]$	9.62E-03	2.90E-03	2.74E-03	2.93E-04	K/W

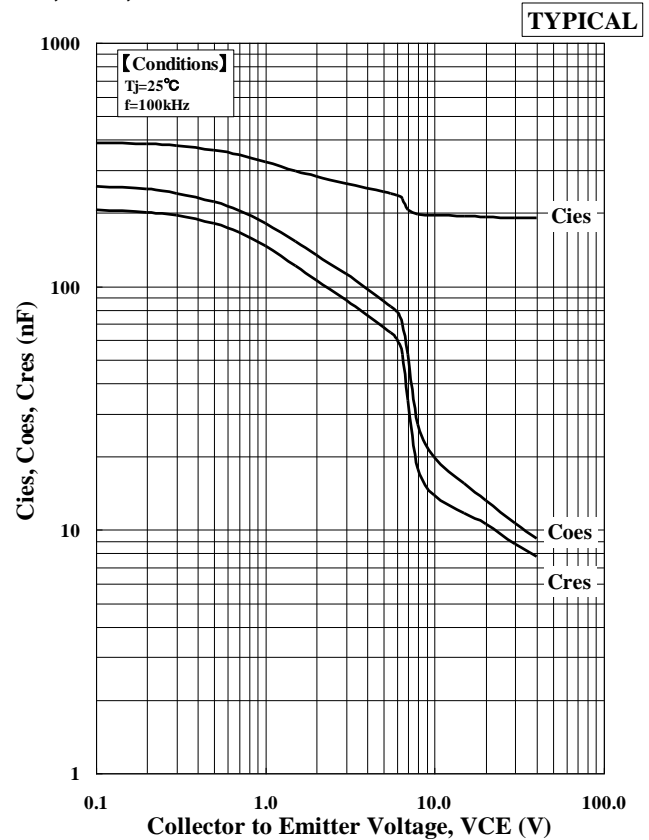
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## QG-VG CURVE



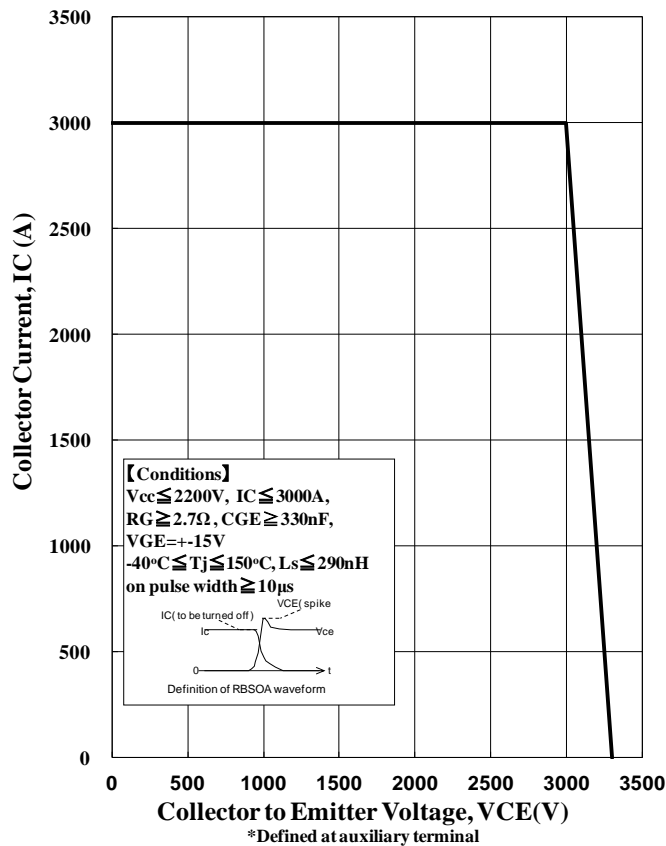
QG-VGE curve

## Cies, Coes, Cres Curve

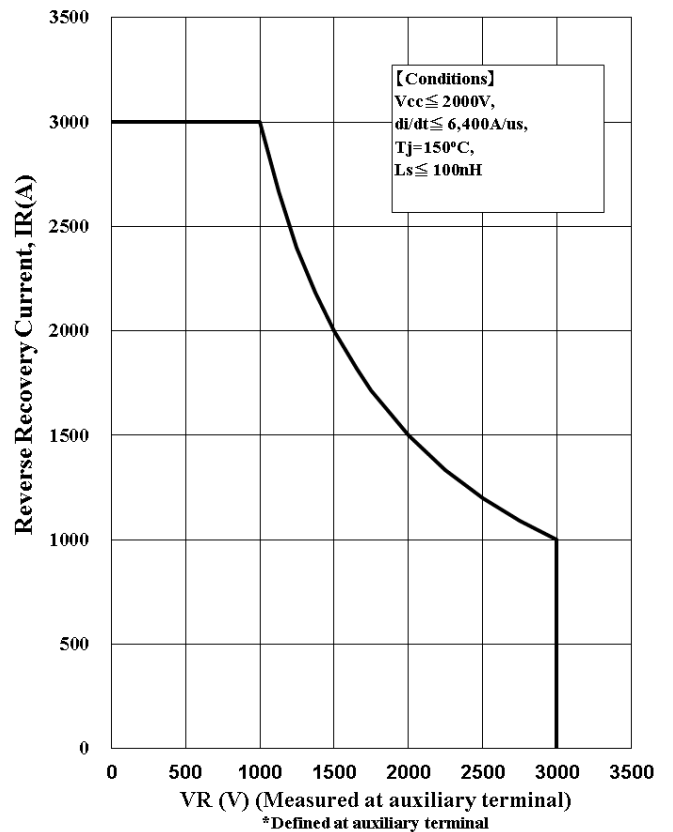


Capacitance vs. Collector to Emitter Voltage

## Safe operation area



Reverse bias Safe operation area (RBSOA)



Reverse recovery Safe operation area (RecSOA)

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## HITACHI POWER SEMICONDUCTORS

### Notices

1. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact Hitachi sales department for the latest version of this data sheets.
2. Please be sure to read "Precautions for Safe Use and Notices" in the individual brochure before use.
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